

# Search Notes



Application/Control No.

10/727,011

Examiner

Hiep T. Nguyen

Applicant(s)/Patent under Reexamination

ASARE ET AL.

Art Unit

2187

## SEARCHED

Class	Subclass	Date	Examiner
711	156	Text search only - see the EAST search print out	
	161		
	162		
713	100		
	187		
714	13	11/27/05 HTP	
	15		
717	170		
	177		

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST search this is attached.	11/27/05	HTP
NPL search using terms similar to EAST search.		
Inventorship search		